

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2493		PRIORITY SERIAL NO. 09/521.092	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary) IDS received on 04/07/2004				APPLICANT Scott E. Moore et al.			
				PRIORITY FILING DATE March 7, 2000		PRIORITY GROUP 3723	
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
AA	5,836,805	11/1998	Obeng				
AB	6,066,030	5/2000	Uzoh				
AC	6,077,147	6/2000	Yang et al.				
AD	6,048,256	4/2000	Obeng et al.				
AE	5,718,620	2/17/98	Tanaka et al.				
AF	5,885,134	3/23/99	Shibata et al.				
AG	6,099,386	8/8/00	Tsai et al.				
AH	6,159,082	12/12/00	Sugiyama et al.				
AI	6,165,048	12/26/00	Russ et al.				
AJ	6,183,352	2/6/01	Kurisawa				
AK	5,653,624	8/5/1997	Ischikawa et al.				
AL	5,923,433	7/13/1999	Giuffre et al.				
AM	6,136,043	10/24/2000	Robinson et al.				
AN	6,482,325 B1	11/19/2002	Corlett et al.				
AO	6,379,538 B1	4/30/2002	Corlett et al.				
AP	5,755,614	5/26/1998	Adams et al.				
AQ	5,664,990	9/9/1997	Adams et al.				
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
AR							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
AS							
EXAMINER /Roy M. Punnoose/				DATE CONSIDERED 01/15/2009			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2493		PRIORITY SERIAL NO. 09/521,092	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Scott E. Moore et al.		PRIORITY FILING DATE March 7, 2000	
				PRIORITY GROUP 3723			
U.S. PATENT DOCUMENTS							
*Examine Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AC						
	AC						
	AC						
	AE						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
	AH						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AI	"The Science and Engineering of Micronelectronic Fabrication", Campbell, Stephen A.; Oxford University Press; 1996; pp. 253-257.					
	AI	http://www.intratechnology.com/html/sensors.htm, Intra Technology, <i>Sensors</i> , 03/25/99, 2 pages					
	AJ	http://www.ftsync.com/complete/analite/analite.htm, FTS, <i>Analite-SDI Turbidity Sensor</i> , 03/25/99, 1 page					
	AK	http://www.customsensors.com/optimax.htm, Custom Sensors & Technology, <i>OptiMax 6000 Series Process Photometric Analyzers</i> , 03/25/99, 2 pages					
	AL	http://www.reflectronics.com/reflectronics_inc_contents.htm, Reflectronics, Inc., <i>Fiber Optic Backscatter Sensor</i> , 03/25/99, 1 page					
	AM	http://www.honeywell.com/sensing/prodinfo/turbidity/technical/turbidity.st, Gary O'Brien, Honeywell, <i>Turbidity Sensor for Electromechanical Dishwasher Control</i> , 1998-1999, 11 pages					
	AT	http://www.impomag.com/O_automa/10970064.htm, ABB Instrumentation, The Stockroom, <i>Photodiode Sensor</i> , 1999, 1 page					
EXAMINER /Roy M. Punnoose/				DATE CONSIDERED 01/15/2009			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							